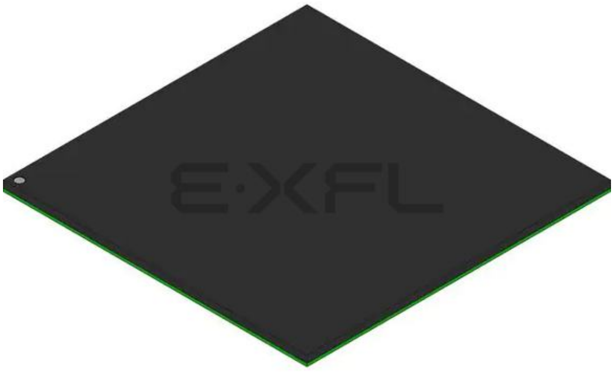


Welcome to **E-XFL.COM**

Understanding Embedded - Microprocessors

Embedded microprocessors are specialized computing chips designed to perform specific tasks within an embedded system. Unlike general-purpose microprocessors found in personal computers, embedded microprocessors are tailored for dedicated functions within larger systems, offering optimized performance, efficiency, and reliability. These microprocessors are integral to the operation of countless electronic devices, providing the computational power necessary for controlling processes, handling data, and managing communications.

Applications of Embedded - Microprocessors

Embedded microprocessors are utilized across a broad spectrum of applications, making them indispensable in

Details	
Product Status	Active
Core Processor	-
Number of Cores/Bus Width	-
Speed	-
Co-Processors/DSP	-
RAM Controllers	-
Graphics Acceleration	-
Display & Interface Controllers	-
Ethernet	-
SATA	-
USB	-
Voltage - I/O	-
Operating Temperature	-
Security Features	-
Package / Case	-
Supplier Device Package	-
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/mpc8265aczumibc

    - Transparent
    - UART (low-speed operation)
  - One serial peripheral interface identical to the MPC860 SPI
  - One inter-integrated circuit (I^2C) controller (identical to the MPC860 I^2C controller)
    - Microwire compatible
    - Multiple-master, single-master, and slave modes
  - Up to eight TDM interfaces (four on the MPC8255)
    - Supports two groups of four TDM channels for a total of eight TDMs
    - 2,048 bytes of SI RAM
    - Bit or byte resolution
    - Independent transmit and receive routing, frame synchronization
    - Supports T1, CEPT, T1/E1, T3/E3, pulse code modulation highway, ISDN basic rate, ISDN primary rate, Freescale interchip digital link (IDL), general circuit interface (GCI), and user-defined TDM serial interfaces
  - Eight independent baud rate generators and 20 input clock pins for supplying clocks to FCCs, SCCs, SMCs, and serial channels
  - Four independent 16-bit timers that can be interconnected as two 32-bit timers

Additional features of the MPC826xA family are as follows:

- CPM
  - 32-Kbyte dual-port RAM
  - Additional MCC host commands
  - Eight transfer transmission convergence (TC) layers between the TDMs and FCC2 to support inverse multiplexing for ATM capabilities (IMA) (MPC8264 and MPC8266 only)
- CPM multiplexing
  - FCC2 can also be connected to the TC layer.
- TC layer (MPC8264 and MPC8266 only)
  - Each of the 8 TDM channels is routed in hardware to a TC layer block
    - Protocol-specific overhead bits may be discarded or routed to other controllers by the SI
    - Performing ATM TC layer functions (according to ITU-T I.432)
    - Transmit (Tx) updates
      - Cell HEC generation
      - Payload scrambling using self synchronizing scrambler (programmable by the user)
      - Coset generation (programmable by the user)
      - Cell rate by inserting idle/unassigned cells
    - Receive (Rx) updates
      - Cell delineation using bit by bit HEC checking and programmable ALPHA and DELTA parameters for the delineation state machine
      - Payload descrambling using self synchronizing scrambler (programmable by the user)

Table 2 lists recommended operational voltage conditions.

Table 2. Recommended Operating Conditions[1]

Rating	Symbol	Value			Unit
Core supply voltage	VDD	1.7 – 1.9[2]	1.7–2.1[3]	1.9 –2.2[4]	V
PLL supply voltage	VCCSYN	1.7 – 1.9[2]	1.7–2.1[3]	1.9–2.2[4]	V
I/O supply voltage	VDDH	3.135 – 3.465			V
Input voltage	VIN	GND (–0.3) – 3.465			V
Junction temperature (maximum)	T_j	105[5]			°C
Ambient temperature	T_A	0–70[5]			°C

[1] **Caution:** These are the recommended and tested operating conditions. Proper device operating outside of these conditions is not guaranteed.

[2] CPU frequency less than or equal to 200 MHz.

[3] CPU frequency greater than 200 MHz but less than 233 MHz.

[4] CPU frequency greater than or equal to 233 MHz.

[5] Note that for extended temperature parts the range is (-40)$_{T_A}$– 105$_{T_j}$.

NOTE: Core, PLL, and I/O Supply Voltages

> VDDH, VCCSYN, and VDD must track each other and both must vary in the same direction—in the positive direction (+5% and +0.1 Vdc) or in the negative direction (–5% and –0.1 Vdc).

This device contains circuitry protecting against damage due to high static voltage or electrical fields; however, it is advised that normal precautions be taken to avoid application of any voltages higher than maximum-rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate logic voltage level (either GND or V_{CC}).

Figure 2 shows the undershoot and overshoot voltage of the 60x and local bus memory interface of the MPC8280. Note that in PCI mode the I/O interface is different.

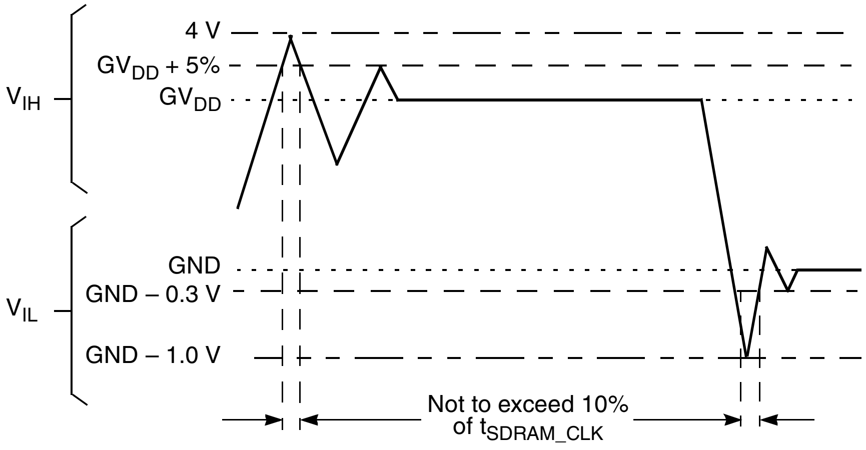


Figure 2. Overshoot/Undershoot Voltage

Table 3. DC Electrical Characteristics[1] (continued)

Characteristic	Symbol	Min	Max	Unit
I_{OL} = 5.3mA $\overline{\text{CS}}$[0-9] $\overline{\text{CS}}$(10)/$\overline{\text{BCTL1}}$ $\overline{\text{CS}}$(11)/AP(0) BADDR[27–28] ALE $\overline{\text{BCTL0}}$ $\overline{\text{PWE}}$(0:7)/$\overline{\text{PSDDQM}}$(0:7)/$\overline{\text{PBS}}$(0:7) PSDA10/PGPL0 $\overline{\text{PSDWE}}$/PGPL1 $\overline{\text{POE}}$/$\overline{\text{PSDRAS}}$/PGPL2 PSDCAS/PGPL3 PGTA/PUPMWAIT/PGPL4/PPBS PSDAMUX/PGPL5 $\overline{\text{LWE}}$[0–3]$\overline{\text{LSDDQM}}$[0–3]/$\overline{\text{LBS}}$[0–3]/PCI_CFG[0–3][3] LSDA10/LGPL0/PCI_MODCKH0[3] LSDWE/LGPL1/PCI_MODCKH1[3] $\overline{\text{LOE}}$/$\overline{\text{LSDRAS}}$/LGPL2/PCI_MODCKH2[3] LSDCAS/LGPL3/PCI_MODCKH3[3] LGTA/LUPMWAIT/LGPL4/$\overline{\text{LPBS}}$ LSDAMUX/LGPL5/PCI_MODCK[3] $\overline{\text{LWR}}$ MODCK1/AP(1)/TC(0)/BNKSEL(0) MODCK2/AP(2)/TC(1)/BNKSEL(1) MODCK3/AP(3)/TC(2)/BNKSEL(2) I_{OL} = 3.2mA L_A14/PAR[3] L_A15/$\overline{\text{FRAME}}$[3]/$\overline{\text{SMI}}$ L_A16/$\overline{\text{TRDY}}$[3] L_A17/$\overline{\text{IRDY}}$[3]/CKSTP_OUT L_A18/$\overline{\text{STOP}}$[3] L_A19/$\overline{\text{DEVSEL}}$[3] L_A20/IDSEL[3] L_A21/$\overline{\text{PERR}}$[3] L_A22/$\overline{\text{SERR}}$[3] L_A23/$\overline{\text{REQ0}}$[3] L_A24/$\overline{\text{REQ1}}$[3]/$\overline{\text{HSEJSW}}$[3] L_A25/$\overline{\text{GNT0}}$[3] L_A26/$\overline{\text{GNT1}}$[3]/$\overline{\text{HSLED}}$[3] L_A27/$\overline{\text{GNT2}}$[3]/$\overline{\text{HSENUM}}$[3] L_A28/$\overline{\text{RST}}$[3]/$\overline{\text{CORE\_SRESET}}$ L_A29/$\overline{\text{INTA}}$[3] L_A30/$\overline{\text{REQ2}}$[3] L_A31 LCL_D(0-31)/AD(0-31)[3] LCL_DP(0-3)/C/$\overline{\text{BE}}$(0-3)[3] PA[0–31] PB[4–31] PC[0–31] PD[4–31] TDO	V_{OL}	—	0.4	V

[1] The default configuration of the CPM pins (PA[0–31], PB[4–31], PC[0–31], PD[4–31]) is input. To prevent excessive DC current, it is recommended to either pull unused pins to GND or VDDH, or to configure them as outputs.

[2] The leakage current is measured for nominal VDD, VCCSYN, and VDD.
[3] MPC8265 and MPC8266 only.

2.2 Thermal Characteristics

Table 4 describes thermal characteristics.

Table 4. Thermal Characteristics for 480 TBGA Package

Characteristics	Symbol	Value	Unit	Air Flow
Junction to ambient	θ_{JA}	13[1]	°C/W	NC[2]
		10[1]		1 m/s
		11[3]		NC
		8[3]		1 m/s
Junction to board[4]	θ_{JB}	4	°C/W	—
Junction to case[5]	θ_{JC}	1.1	°C/W	—

[1] Assumes a single layer board with no thermal vias
[2] Natural convection
[3] Assumes a four layer board
[4] Thermal resistance between the die and the printed circuit board per JEDEC JESD51-8. Board temperature is measured on the top surface of the board near the package.
[5] Thermal resistance between the die and the case top surface as measured by the cold plate method (MIL SPEC-883 Method 1012.1).

2.3 Power Considerations

The average chip-junction temperature, T_J, in °C can be obtained from the following:

$$T_J = T_A + (P_D \times \theta_{JA}) \qquad (1)$$

where

T_A = ambient temperature °C

θ_{JA} = package thermal resistance, junction to ambient, °C/W

$P_D = P_{INT} + P_{I/O}$

$P_{INT} = I_{DD} \times V_{DD}$ Watts (chip internal power)

$P_{I/O}$ = power dissipation on input and output pins (determined by user)

For most applications $P_{I/O} < 0.3 \times P_{INT}$. If $P_{I/O}$ is neglected, an approximate relationship between P_D and T_J is the following:

$$P_D = K/(T_J + 273^\circ\ C) \qquad (2)$$

Solving equations (1) and (2) for K gives:

$$K = P_D \times (T_A + 273^\circ\ C) + \theta_{JA} \times P_D^2 \qquad (3)$$

2.4 AC Electrical Characteristics

The following sections include illustrations and tables of clock diagrams, signals, and CPM outputs and inputs for the 66 MHz MPC826xA device. Note that AC timings are based on a 50-p*f* load. Typical output buffer impedances are shown in Table 6.

Table 6. Output Buffer Impedances[1]

Output Buffers	Typical Impedance (Ω)
60x bus	40
Local bus	40
Memory controller	40
Parallel I/O	46
PCI	25

[1] These are typical values at 65° C. The impedance may vary by ±25% with process and temperature.

Table 7 lists CPM output characteristics.

Table 7. AC Characteristics for CPM Outputs[1]

Spec Number		Characteristic	Max Delay (ns)		Min Delay (ns)	
Max	Min		66 MHz	83 MHz	66 MHz	83 MHz
sp36a	sp37a	FCC outputs—internal clock (NMSI)	6	5.5	1	1
sp36b	sp37b	FCC outputs—external clock (NMSI)	14	12	2	1
sp40	sp41	TDM outputs/SI	25	16	5	4
sp38a	sp39a	SCC/SMC/SPI/I2C outputs—internal clock (NMSI)	19	16	1	0.5
sp38b	sp39b	Ex_SCC/SMC/SPI/I2C outputs—external clock (NMSI)	19	16	2	1
sp42	sp43	TIMER/IDMA outputs	14	11	1	0.5
sp42a	sp43a	PIO outputs	14	11	0.5	0.5

[1] Output specifications are measured from the 50% level of the rising edge of CLKIN to the 50% level of the signal. Timings are measured at the pin.

Table 8 lists CPM input characteristics.

Table 8. AC Characteristics for CPM Inputs[1]

Spec Number		Characteristic	Setup (ns)		Hold (ns)	
Max	Min		66 MHz	83 MHz	66 MHz	83 MHz
sp16a	sp17a	FCC inputs—internal clock (NMSI)	10	8	0	0
sp16b	sp17b	FCC inputs—external clock (NMSI)	3	2.5	3	2
sp20	sp21	TDM inputs/SI	15	12	12	10
sp18a	sp19a	SCC/SMC/SPI/I2C inputs—internal clock (NMSI)	20	16	0	0
sp18b	sp19b	SCC/SMC/SPI/I2C inputs—external clock (NMSI)	5	4	5	4
sp22	sp23	PIO/TIMER/IDMA inputs	10	8	3	3

[1] Input specifications are measured from the 50% level of the signal to the 50% level of the rising edge of CLKIN. Timings are measured at the pin.

Note that although the specifications generally reference the rising edge of the clock, the following AC timing diagrams also apply when the falling edge is the active edge.

Figure 3 shows the FCC external clock.

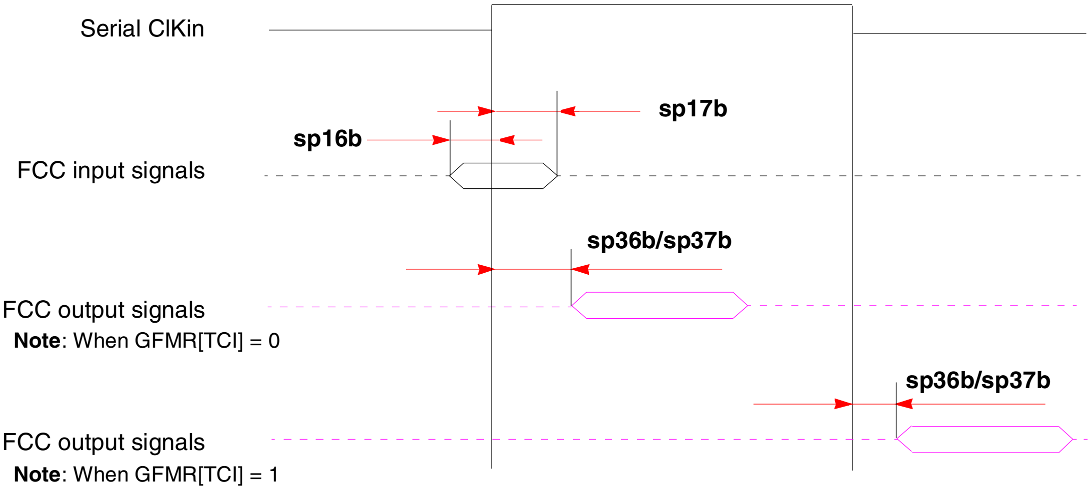


Figure 3. FCC External Clock Diagram

Figure 4 shows the FCC internal clock.

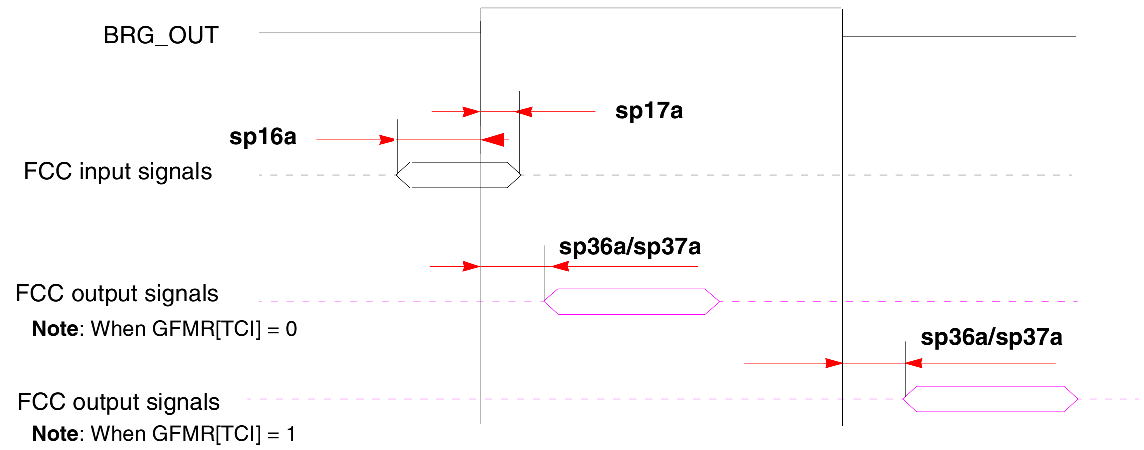
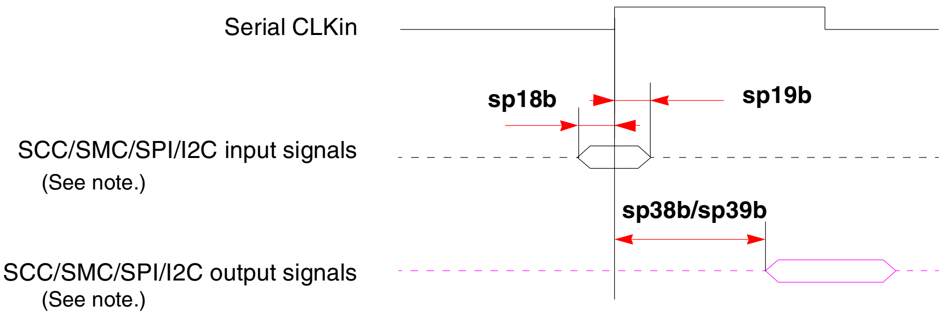


Figure 4. FCC Internal Clock Diagram

Figure 5 shows the SCC/SMC/SPI/I^{2}C external clock.

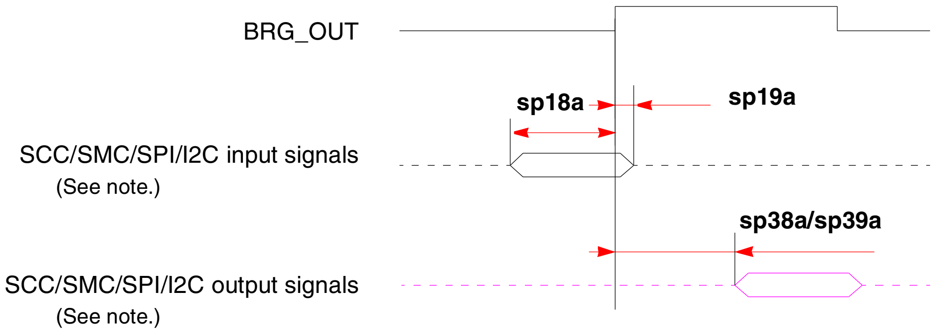


Note: There are four possible timing conditions for SCC and SPI:

1. Input sampled on the rising edge and output driven on the rising edge (shown).
2. Input sampled on the rising edge and output driven on the falling edge.
3. Input sampled on the falling edge and output driven on the falling edge.
4. Input sampled on the falling edge and output driven on the rising edge.

Figure 5. SCC/SMC/SPI/I^{2}C External Clock Diagram

Figure 6 shows the SCC/SMC/SPI/I^{2}C internal clock.

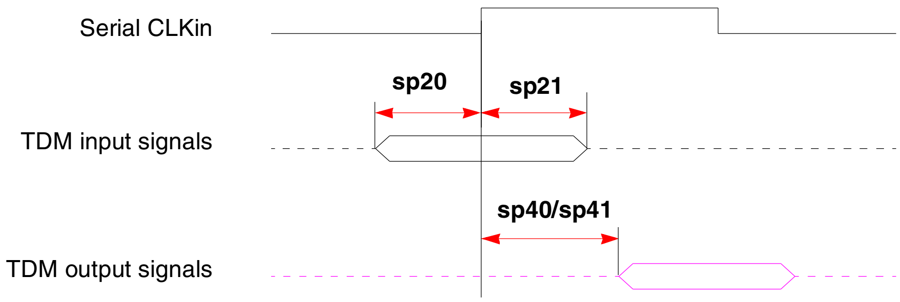


Note: There are four possible timing conditions for SCC and SPI:

1. Input sampled on the rising edge and output driven on the rising edge (shown).
2. Input sampled on the rising edge and output driven on the falling edge.
3. Input sampled on the falling edge and output driven on the falling edge.
4. Input sampled on the falling edge and output driven on the rising edge.

Figure 6. SCC/SMC/SPI/I^{2}C Internal Clock Diagram

Figure 7 shows TDM input and output signals.

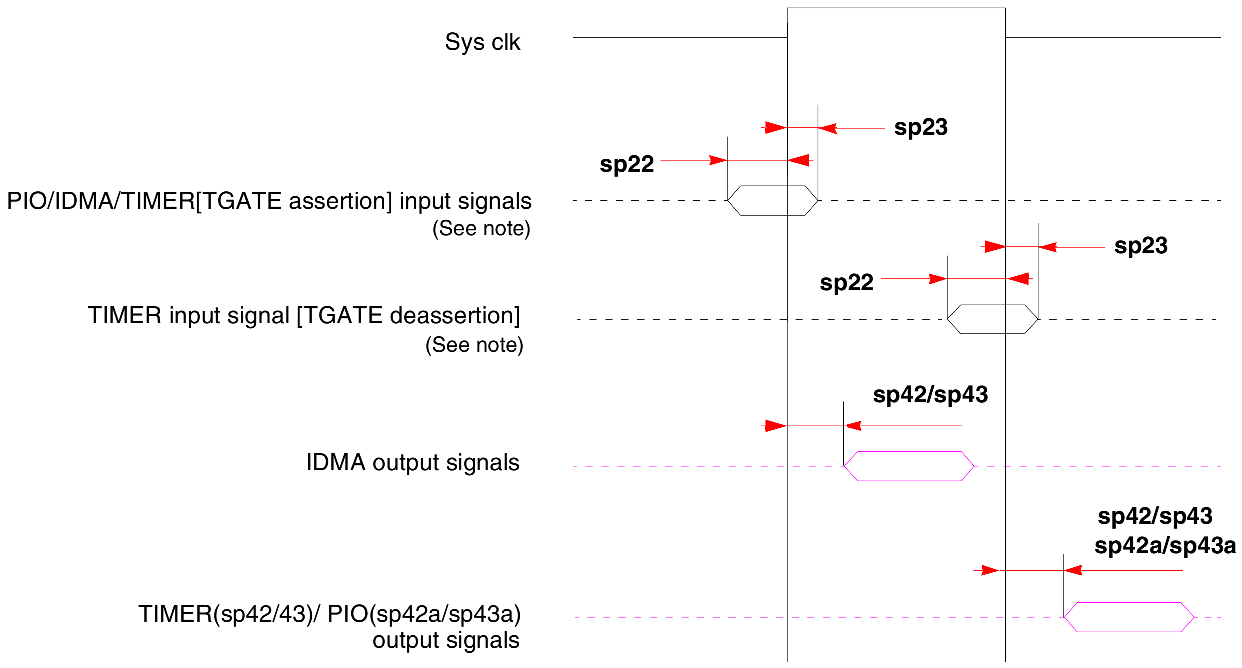


Note: There are four possible TDM timing conditions:

1. Input sampled on the rising edge and output driven on the rising edge (shown).
2. Input sampled on the rising edge and output driven on the falling edge.
3. Input sampled on the falling edge and output driven on the falling edge.
4. Input sampled on the falling edge and output driven on the rising edge.

Figure 7. TDM Signal Diagram

Figure 8 shows PIO, timer, and DMA signals.



Note: TGATE is asserted on the rising edge of the clock; it is deasserted on the falling edge.

Figure 8. PIO, Timer, and DMA Signal Diagram

Table 10 lists SIU input characteristics.

Table 9. AC Characteristics for SIU Inputs[1]

Spec Number		Characteristic	Setup (ns)		Hold (ns)	
Max	Min		66 MHz	83 MHz	66 MHz	83 MHz
sp11	sp10	$\overline{\text{AACK}}/\overline{\text{ARTRY}}/\overline{\text{TA}}/\overline{\text{TS}}/\overline{\text{TEA}}/\overline{\text{DBG}}/\overline{\text{BG}}/\overline{\text{BR}}$	6	5	0.5	0.5
sp12	sp10	Data bus in normal mode	5	4	0.5	0.5
sp13	sp10	Data bus in ECC and PARITY modes	8	6	0.5	0.5
sp14	sp10	DP pins	7	6	0.5	0.5
sp15	sp10	All other pins	5	4	0.5	0.5

[1] Input specifications are measured from the 50% level of the signal to the 50% level of the rising edge of CLKIN. Timings are measured at the pin.

Table 10 lists SIU output characteristics.

Table 10. AC Characteristics for SIU Outputs[1]

Spec Number		Characteristic	Max Delay (ns)		Min Delay (ns)	
Max	Min		66 MHz	83 MHz	66 MHz	83 MHz
sp31	sp30	$\overline{\text{PSDVAL}}$/$\overline{\text{TEA}}$/$\overline{\text{TA}}$	7	6	0.5	0.5
sp32	sp30	ADD/ADD_atr./BADDR/CI/GBL/WT	8	6.5	0.5	0.5
sp33a	sp30	Data bus	6.5	6.5	0.5	0.5
sp33b	sp30	DP	8	7	0.5	0.5
sp34	sp30	Memory controller signals/ALE	6	5	0.5	0.5
sp35	sp30	All other signals	6	5.5	0.5	0.5

[1] Output specifications are measured from the 50% level of the rising edge of CLKIN to the 50% level of the signal. Timings are measured at the pin.

NOTE

Activating data pipelining (setting BR*x*[DR] in the memory controller) improves the AC timing. When data pipelining is activated, sp12 can be used for data bus setup even when ECC or PARITY are used. Also, sp33a can be used as the AC specification for DP signals.

Figure 9 shows the interaction of several bus signals.

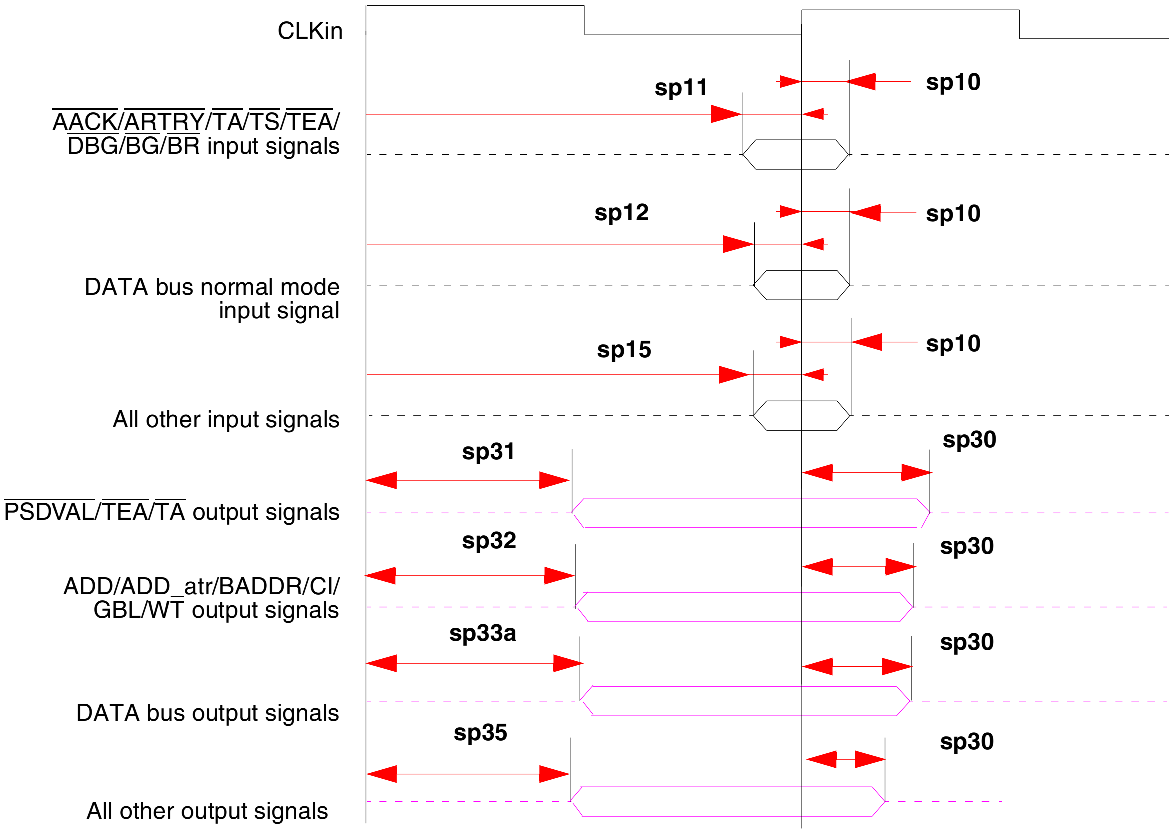


Figure 9. Bus Signals

Figure 10 shows signal behavior for all parity modes (including ECC, RMW parity, and standard parity).

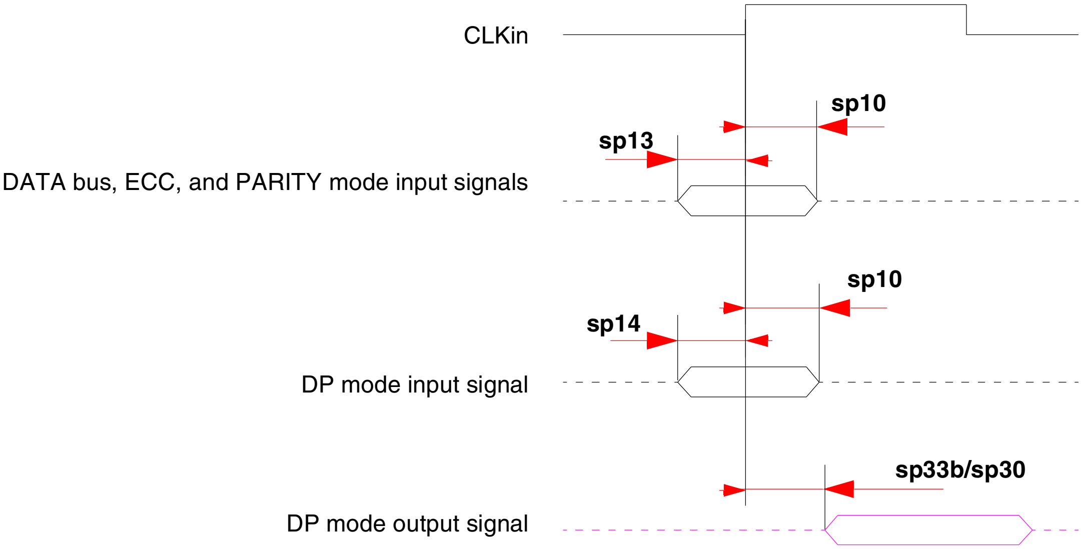


Figure 10. Parity Mode Diagram

Table 12 lists the JTAG timings.

Table 12. JTAG Timings[1]

Parameter	Symbol[2]	Min	Max	Unit	Notes
JTAG external clock frequency of operation	f_{JTG}	0	25	MHz	—
JTAG external clock cycle time	t_{JTG}	40	—	ns	—
JTAG external clock pulse width measured at 1.4V	t_{JTKHKL}	20	—	ns	—
JTAG external clock rise and fall times	t_{JTGR} and t_{JTGF}	0	5	ns	6
TRST assert time	t_{TRST}	25	—	ns	3, 6
Input setup times					
Boundary-scan data	t_{JTDVKH}	4	—	ns	4, 7
TMS, TDI	t_{JTIVKH}	4	—	ns	4, 7
Input hold times					
Boundary-scan data	t_{JTDXKH}	10	—	ns	4, 7
TMS, TDI	t_{JTIXKH}	10	—	ns	4, 7
Output valid times					
Boundary-scan data	t_{JTKLDV}	—	25	ns	5, 7
TDO	t_{JTKLOV}	—	25	ns	5. 7
Output hold times					
Boundary-scan data	t_{JTKLDX}	1	—	ns	5, 7
TDO	t_{JTKLOX}	1	—	ns	5, 7
JTAG external clock to output high impedance					
Boundary-scan data	t_{JTKLDZ}	1	25	ns	5, 6
TDO	t_{JTKLOZ}	1	25	ns	5, 6

[1] All outputs are measured from the midpoint voltage of the falling/rising edge of t_{TCLK} to the midpoint of the signal in question. The output timings are measured at the pins. All output timings assume a purely resistive 50-Ω load. Time-of-flight delays must be added for trace lengths, vias, and connectors in the system.

[2] The symbols used for timing specifications herein follow the pattern of $t_{\text{(first two letters of functional block)(signal)(state)(reference)(state)}}$ for inputs and $t(_{\text{(first two letters of functional block)(reference)(state)(signal)(state)}}$ for outputs. For example, t_{JTDVKH} symbolizes JTAG device timing (JT) with respect to the time data input signals (D) reaching the valid state (V) relative to the t_{JTG} clock reference (K) going to the high (H) state or setup time. Also, t_{JTDXKH} symbolizes JTAG timing (JT) with respect to the time data input signals (D) went invalid (X) relative to the t_{JTG} clock reference (K) going to the high (H) state. Note that, in general, the clock reference symbol representation is based on three letters representing the clock of a particular functional. For rise and fall times, the latter convention is used with the appropriate letter: R (rise) or F (fall).

[3] TRST is an asynchronous level sensitive signal. The setup time is for test purposes only.

[4] Non-JTAG signal input timing with respect to t_{TCLK}.

[5] Non-JTAG signal output timing with respect to t_{TCLK}.

[6] Guaranteed by design.

[7] Guaranteed by design and device characterization.

NOTE

The UPM machine outputs change on the internal tick determined by the memory controller programming; the AC specifications are relative to the internal tick. Note that SDRAM and GPCM machine outputs change on CLKin’s rising edge.

3 Clock Configuration Modes

To configure the main PLL multiplication factor and the core, CPM, and 60x bus frequencies, the MODCK[1–3] pins are sampled while $\overline{\text{HRESET}}$ is asserted. Table 13 lists the eight basic configuration modes. Table 14 lists the other modes that are available by using the configuration pin ($\overline{\text{RSTCONF}}$) and driving four bits from hardware configuration word on the data bus.

Note that the MPC8265 and the MPC8266 have two additional clocking modes—PCI agent and PCI host. Refer to Section 3.2, “PCI Mode” on page 26 for information.

NOTE

Clock configurations change only after $\overline{\text{POR}}$ is asserted.

3.1 Local Bus Mode

Table 13 describes default clock modes for the MPC826xA.

Table 13. Clock Default Modes

MODCK[1–3]	Input Clock Frequency	CPM Multiplication Factor	CPM Frequency	Core Multiplication Factor	Core Frequency
000	33 MHz	3	100 MHz	4	133 MHz
001	33 MHz	3	100 MHz	5	166 MHz
010	33 MHz	4	133 MHz	4	133 MHz
011	33 MHz	4	133 MHz	5	166 MHz
100	66 MHz	2	133 MHz	2.5	166 MHz
101	66 MHz	2	133 MHz	3	200 MHz
110	66 MHz	2.5	166 MHz	2.5	166 MHz
111	66 MHz	2.5	166 MHz	3	200 MHz

Table 14 describes all possible clock configurations when using the hard reset configuration sequence. Note that basic modes are shown in boldface type. The frequencies listed are for the purpose of illustration only. Users must select a mode and input bus frequency so that the resulting configuration does not exceed the frequency rating of the user’s device.

Table 14. Clock Configuration Modes[1]

MODCK_H–MODCK[1–3]	Input Clock Frequency[2,3]	CPM Multiplication Factor[2]	CPM Frequency[2]	Core Multiplication Factor[2]	Core Frequency[2]
0001_000	33 MHz	2	66 MHz	4	133 MHz
0001_001	33 MHz	2	66 MHz	5	166 MHz
0001_010	33 MHz	2	66 MHz	6	200 MHz
0001_011	33 MHz	2	66 MHz	7	233 MHz
0001_100	33 MHz	2	66 MHz	8	266 MHz

Table 14. Clock Configuration Modes[1] (continued)

MODCK_H–MODCK[1–3]	Input Clock Frequency[2,3]	CPM Multiplication Factor[2]	CPM Frequency[2]	Core Multiplication Factor[2]	Core Frequency[2]
0001_101	33 MHz	3	100 MHz	4	133 MHz
0001_110	33 MHz	3	100 MHz	5	166 MHz
0001_111	33 MHz	3	100 MHz	6	200 MHz
0010_000	33 MHz	3	100 MHz	7	233 MHz
0010_001	33 MHz	3	100 MHz	8	266 MHz
0010_010	**33 MHz**	**4**	**133 MHz**	**4**	**133 MHz**
0010_011	**33 MHz**	**4**	**133 MHz**	**5**	**166 MHz**
0010_100	33 MHz	4	133 MHz	6	200 MHz
0010_101	33 MHz	4	133 MHz	7	233 MHz
0010_110	33 MHz	4	133 MHz	8	266 MHz
0010_111	33 MHz	5	166 MHz	4	133 MHz
0011_000	33 MHz	5	166 MHz	5	166 MHz
0011_001	33 MHz	5	166 MHz	6	200 MHz
0011_010	33 MHz	5	166 MHz	7	233 MHz
0011_011	33 MHz	5	166 MHz	8	266 MHz
0011_100	33 MHz	6	200 MHz	4	133 MHz
0011_101	33 MHz	6	200 MHz	5	166 MHz
0011_110	33 MHz	6	200 MHz	6	200 MHz
0011_111	33 MHz	6	200 MHz	7	233 MHz
0100_000	33 MHz	6	200 MHz	8	266 MHz
0100_001	Reserved				
0100_010					
0100_011					
0100_100					
0100_101					
0100_110					

Table 14. Clock Configuration Modes[1] (continued)

MODCK_H–MODCK[1–3]	Input Clock Frequency[2,3]	CPM Multiplication Factor[2]	CPM Frequency[2]	Core Multiplication Factor[2]	Core Frequency[2]
1000_001	66 MHz	3.5	233 MHz	3	200 MHz
1000_010	66 MHz	3.5	233 MHz	3.5	233 MHz
1000_011	66 MHz	3.5	233 MHz	4	266 MHz
1000_100	66 MHz	3.5	233 MHz	4.5	300 MHz

[1] Because of speed dependencies, not all of the possible configurations in Table 14 are applicable.

[2] The user should choose the input clock frequency and the multiplication factors such that the frequency of the CPU is equal to or greater than 150 MHz and the CPM ranges between 66–233 MHz.

[3] Input clock frequency is given only for the purpose of reference. The user should set MODCK_H–MODCK_L so that the resulting configuration does not exceed the frequency rating of the user's part.

3.2 PCI Mode

The MPC8265 and the MPC8266 have three clocking modes: local, PCI host, and PCI agent. The clocking mode is set according to three input pins—PCI_MODE, PCI_CFG[0], PCI_MODCK—as shown in Table 15.

Table 15. MPC8265 and MPC8266 Clocking Modes

Pins			Clocking Mode	PCI Clock Frequency Range (MHZ)
PCI_MODE	PCI_CFG[0]	PCI_MODCK		
1	—	—	Local bus	—
0	0	0	PCI host	50–66
0	0	1		25–50
0	1	0	PCI agent	50–66
0	1	1		25–50

In addition, note the following:

NOTE: PCI_MODCK

In PCI mode only, PCI_MODCK comes from the LGPL5 pin and MODCK_H[0–3] comes from {LGPL0, LGPL1, LGPL2, LGPL3}.

NOTE: Tval (Output Hold)

The minimum Tval = 2 when PCI_MODCK = 1, and the minimum Tval = 1 when PCI_MODCK = 0. Therefore, designers should use clock configurations that fit this condition to achieve PCI-compliant AC timing.

NOTE

Clock configurations change only after $\overline{\text{POR}}$ is asserted.

Table 17. Clock Configuration Modes in PCI Host Mode (continued)

MODCK_H – MODCK[1–3]	Input Clock Frequency[1] (Bus)	CPM Multiplication Factor	CPM Frequency	Core Multiplication Factor	Core Frequency	PCI Division Factor[2]	PCI Frequency[2]
0011_011[3]	33 MHz	5	166 MHz	8	266 MHz	5	33 MHz
0100_000[3]	33 MHz	6	200 MHz	5	166 MHz	6	33 MHz
0100_001[3]	33 MHz	6	200 MHz	6	200 MHz	6	33 MHz
0100_010[3]	33 MHz	6	200 MHz	7	233 MHz	6	33 MHz
0100_011[3]	33 MHz	6	200 MHz	8	266 MHz	6	33 MHz
0101_000	**66 MHz**	**2**	**133 MHz**	**2.5**	**166 MHz**	**2/4**	**66/33 MHz**
0101_001	**66 MHz**	**2**	**133 MHz**	**3**	**200 MHz**	**2/**4	**66**/33 **MHz**
0101_010	66 MHz	2	133 MHz	3.5	233 MHz	2/4	66/33 MHz
0101_011	66 MHz	2	133 MHz	4	266 MHz	2/4	66/33 MHz
0101_100	66 MHz	2	133 MHz	4.5	300 MHz	2/4	66/33 MHz
0110_000	**66 MHz**	**2.5**	**166 MHz**	**2.5**	**166 MHz**	3/6	**55/28 MHz**
0110_001	**66 MHz**	**2.5**	**166 MHz**	**3**	**200 MHz**	3/6	55/28 MHz
0110_010	66 MHz	2.5	166 MHz	3.5	233 MHz	3/6	55/28 MHz
0110_011	66 MHz	2.5	166 MHz	4	266 MHz	3/6	55/28 MHz
0110_100	66 MHz	2.5	166 MHz	4.5	300 MHz	3/6	55/28 MHz
0111_000	66 MHz	3	200 MHz	2.5	166 MHz	3/6	66/33 MHz
0111_001	66 MHz	3	200 MHz	3	200 MHz	3/6	66/33 MHz
0111_010	66 MHz	3	200 MHz	3.5	233 MHz	3/6	66/33 MHz
0111_011	66 MHz	3	200 MHz	4	266 MHz	3/6	66/33 MHz
0111_100	66 MHz	3	200 MHz	4.5	300 MHz	3/6	66/33 MHz
1000_000	66 MHz	3	200 MHz	2.5	166 MHz	4/8	50/25 MHz
1000_001	66 MHz	3	200 MHz	3	200 MHz	4/8	50/25 MHz
1000_010	66 MHz	3	200 MHz	3.5	233 MHz	4/8	50/25 MHz
1000_011	66 MHz	3	200 MHz	4	266 MHz	4/8	50/25 MHz
1000_100	66 MHz	3	200 MHz	4.5	300 MHz	4/8	50/25 MHz
1001_000	66 MHz	3.5	233 MHz	2.5	166 MHz	4/8	58/29 MHz
1001_001	66 MHz	3.5	233 MHz	3	200 MHz	4/8	58/29 MHz

Table 19. Clock Configuration Modes in PCI Agent Mode (continued)

MODCK_H – MODCK[1–3]	Input Clock Frequency (PCI)[1,2]	CPM Multiplication Factor[1]	CPM Frequency	Core Multiplication Factor	Core Frequency[3]	Bus Division Factor	60x Bus Frequency[4]
1010_001	66/33 MHz	4/8	266 MHz	3	266 MHz	3	88 MHz
1010_010	66/33 MHz	4/8	266 MHz	3.5	300 MHz	3	88 MHz
1010_011	66/33 MHz	4/8	266 MHz	4	350 MHz	3	88 MHz
1010_100	66/33 MHz	4/8	266 MHz	4.5	400 MHz	3	88 MHz
1011_000	66/33 MHz	4/8	266 MHz	2	212MHz	2.5	106 MHz
1011_001	66/33 MHz	4/8	266 MHz	2.5	265 MHz	2.5	106 MHz
1011_010	66/33 MHz	4/8	266 MHz	3	318 MHz	2.5	106 MHz
1011_011	66/33 MHz	4/8	266 MHz	3.5	371 MHz	2.5	106 MHz
1011_100	66/33 MHz	4/8	266 MHz	4	424 MHz	2.5	106 MHz

[1] The frequency depends on the value of PCI_MODCK. If PCI_MODCK is high (logic ‘1’), the PCI frequency is divided by 2 (33 instead of 66 MHz, etc.) and the CPM multiplication factor is multiplied by 2. Refer to Table 15.

[2] Input clock frequency is given only for the purpose of reference. User should set MODCK_H–MODCK_L so that the resulting configuration does not exceed the frequency rating of the user’s part.

[3] Core frequency = (60x bus frequency)(core multiplication factor)

[4] Bus frequency = CPM frequency/bus division factor

[5] In this mode, PCI_MODCK must be “1”.

Table 21. Pinout List (continued)

Pin Name	Ball
PWE4/PSDDQM4/PBS4	B26
PWE5/PSDDQM5/PBS5	A26
PWE6/PSDDQM6/PBS6	B25
PWE7/PSDDQM7/PBS7	A25
PSDA10/PGPL0	E23
$\overline{\text{PSDWE}}$/PGPL1	B24
$\overline{\text{POE}}$/$\overline{\text{PSDRAS}}$/PGPL2	A24
$\overline{\text{PSDCAS}}$/PGPL3	B23
$\overline{\text{PGTA}}$/PUPMWAIT/PGPL4/$\overline{\text{PPBS}}$	A23
PSDAMUX/PGPL5	D22
LWE0/LSDDQM0/$\overline{\text{LBS0}}$/PCI_CFG0[1]	H28
LWE1/LSDDQM1/LBS1/PCI_CFG1[1]	H27
LWE2/LSDDQM2/LBS2/PCI_CFG2[1]	H26
LWE3/LSDDQM3/LBS3/PCI_CFG3[1]	G29
LSDA10/LGPL0/PCI_MODCKH0[1]	D27
$\overline{\text{LSDWE}}$/LGPL1/PCI_MODCKH1[1]	C28
$\overline{\text{LOE}}$/$\overline{\text{LSDRAS}}$/LGPL2/PCI_MODCKH2[1]	E26
$\overline{\text{LSDCAS}}$/LGPL3/PCI_MODCKH3[1]	D25
$\overline{\text{LGTA}}$/LUPMWAIT/LGPL4/$\overline{\text{LPBS}}$	C26
LGPL5/LSDAMUX/PCI_MODCK[1]	B27
LWR	D28
L_A14/PAR[1]	N27
L_A15/$\overline{\text{FRAME}}$[1]/$\overline{\text{SMI}}$	T29
L_A16/$\overline{\text{TRDY}}$[1]	R27
L_A17/$\overline{\text{IRDY}}$[1]/$\overline{\text{CKSTP\_OUT}}$	R26
L_A18/$\overline{\text{STOP}}$[1]	R29
L_A19/$\overline{\text{DEVSEL}}$[1]	R28
L_A20/IDSEL[1]	W29
L_A21/$\overline{\text{PERR}}$[1]	P28
L_A22/$\overline{\text{SERR}}$[1]	N26
L_A23/$\overline{\text{REQ0}}$[1]	AA27
L_A24/$\overline{\text{REQ1}}$[1]/HSEJSW[1]	P29
L_A25/$\overline{\text{GNT0}}$[1]	AA26
L_A26/$\overline{\text{GNT1}}$[1]/HSLED[1]	N25
L_A27/$\overline{\text{GNT2}}$[1]/$\overline{\text{HSENUM}}$[1]	AA25

Table 21. Pinout List (continued)

Pin Name	Ball
L_A28/$\overline{\text{RST}}$[1]/$\overline{\text{CORE\_SRESET}}$	AB29
L_A29/$\overline{\text{INTA}}$[1]	AB28
L_A30/$\overline{\text{REQ2}}$[1]	P25
L_A31/DLLOUT[1]	AB27
LCL_D0/AD0[1]	H29
LCL_D1/AD1[1]	J29
LCL_D2/AD2[1]	J28
LCL_D3/AD3[1]	J27
LCL_D4/AD4[1]	J26
LCL_D5/AD5[1]	J25
LCL_D6/AD6[1]	K25
LCL_D7/AD7[1]	L29
LCL_D8/AD8[1]	L27
LCL_D9/AD9[1]	L26
LCL_D10/AD10[1]	L25
LCL_D11/AD11[1]	M29
LCL_D12/AD12[1]	M28
LCL_D13/AD13[1]	M27
LCL_D14/AD14[1]	M26
LCL_D15/AD15[1]	N29
LCL_D16/AD16[1]	T25
LCL_D17/AD17[1]	U27
LCL_D18/AD18[1]	U26
LCL_D19/AD19[1]	U25
LCL_D20/AD20[1]	V29
LCL_D21/AD21[1]	V28
LCL_D22/AD22[1]	V27
LCL_D23/AD23[1]	V26
LCL_D24/AD24[1]	W27
LCL_D25/AD25[1]	W26
LCL_D26/AD26[1]	W25
LCL_D27/AD27[1]	Y29
LCL_D28/AD28[1]	Y28
LCL_D29/AD29[1]	Y25
LCL_D30/AD30[1]	AA29

How to Reach Us:

Home Page:
www.freescale.com

Web Support:
http://www.freescale.com/support

USA/Europe or Locations Not Listed:
Freescale Semiconductor, Inc.
Technical Information Center, EL516
2100 East Elliot Road
Tempe, Arizona 85284
1-800-521-6274 or
+1-480-768-2130
www.freescale.com/support

Europe, Middle East, and Africa:
Freescale Halbleiter Deutschland GmbH
Technical Information Center
Schatzbogen 7
81829 Muenchen, Germany
+44 1296 380 456 (English)
+46 8 52200080 (English)
+49 89 92103 559 (German)
+33 1 69 35 48 48 (French)
www.freescale.com/support

Japan:
Freescale Semiconductor Japan Ltd.
Headquarters
ARCO Tower 15F
1-8-1, Shimo-Meguro, Meguro-ku
Tokyo 153-0064
Japan
0120 191014 or
+81 3 5437 9125
support.japan@freescale.com

Asia/Pacific:
Freescale Semiconductor China Ltd.
Exchange Building 23F
No. 118 Jianguo Road
Chaoyang District
Beijing 100022
China
+86 10 5879 8000
support.asia@freescale.com

For Literature Requests Only:
Freescale Semiconductor
Literature Distribution Center
1-800 441-2447 or
+1-303-675-2140
Fax: +1-303-675-2150
LDCForFreescaleSemiconductor
@hibbertgroup.com

Information in this document is provided solely to enable system and software implementers to use Freescale Semiconductor products. There are no express or implied copyright licenses granted hereunder to design or fabricate any integrated circuits or integrated circuits based on the information in this document.

Freescale Semiconductor reserves the right to make changes without further notice to any products herein. Freescale Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does Freescale Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation consequential or incidental damages. "Typical" parameters which may be provided in Freescale Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. Freescale Semiconductor does not convey any license under its patent rights nor the rights of others. Freescale Semiconductor products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the Freescale Semiconductor product could create a situation where personal injury or death may occur. Should Buyer purchase or use Freescale Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold Freescale Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that Freescale Semiconductor was negligent regarding the design or manufacture of the part.

Freescale, the Freescale logo, and StarCore are trademarks or registered trademarks of Freescale Semiconductor, Inc. in the U.S. and other countries. All other product or service names are the property of their respective owners. The Power Architecture and Power.org word marks and the Power and Power.org logos and related marks are trademarks and service marks licensed by Power.org. IEEE 802.3 and 1149.1 are registered trademarks of the Institute of Electrical and Electronics Engineers, Inc. (IEEE). This product is not endorsed or approved by the IEEE.

© Freescale Semiconductor, Inc., 2005–2009. All rights reserved.

Document Number: MPC8260AEC
Rev. 2.0
06/2009